

Search Notes

Application/Control No.

10/532,619

Examiner

Emmanuel Bayard

Applicant(s)/Patent under
Reexamination

CHEN, ERNEST C.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	295	11/28/2007	EB
375	262	11/28/2007	EB
375	324	11/28/2007	EB
375	265	11/28/2007	EB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	295	11/28/2007	EB
375	324	11/28/2007	EB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	11/28/2007	EB